Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/661.157	OWENS ET AL.

Craig M. Schneider

Examiner

Reexamination
OWENS ET AL.
Art Unit
3753

SEARCHED					
Class	Subclass	Date	Examiner		
137	382	12/1/2005	смѕ		
137	377	12/1/2005	CMS		
70	158	12/2/2005	смѕ		
70	178	12/2/2005	CMS		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Search from J. Rivell	12/1/2005	смѕ		
East and Word search per attached	12/1/2005	смѕ		
Inventor search in PALM (Owens, Mitchell and Wyman, Michael)	12/1/2005	смѕ		